Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/699,691	LIANG ET AL.	
Examiner	Art Unit	
TUYEN T. NGUYEN	2832	

	SEAR	CHED	
Class	Subclass	Date	Examiner
336	180-184, 199-208, 223, 232	3/7/2005	TTN
1			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
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